

TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process)

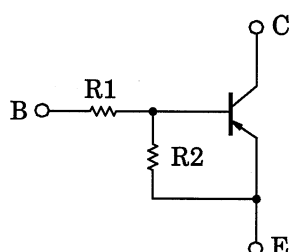
RN2107F, RN2108F, RN2109F

Switching, Inverter Circuit, Interface Circuit
and Driver Circuit Applications

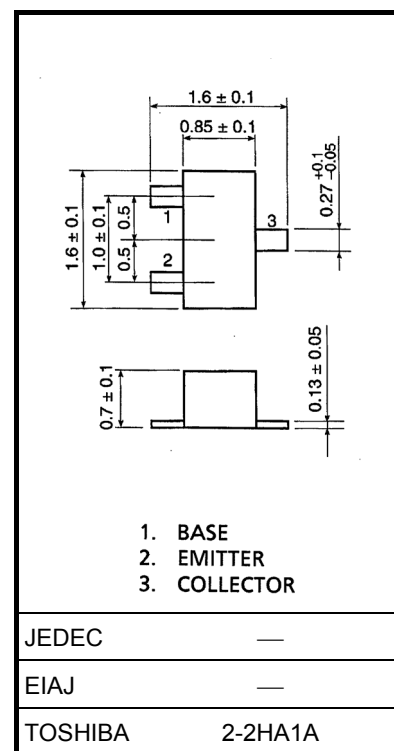
Unit: mm

- With built-in bias resistors
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process
- Complementary to RN1107F~RN1109F

Equivalent Circuit and Bias Resistor Values



Type No.	R1 (kΩ)	R2 (kΩ)
RN2107F	10	47
RN2108F	22	47
RN2109F	47	22



Absolute Maximum Ratings (Ta = 25°C)

Weight: 2.3 mg (typ.)

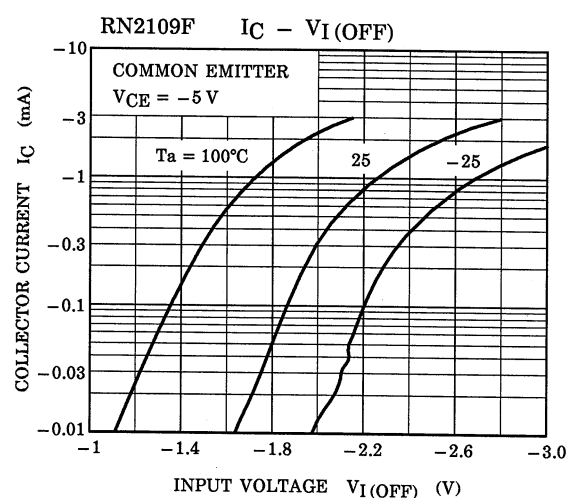
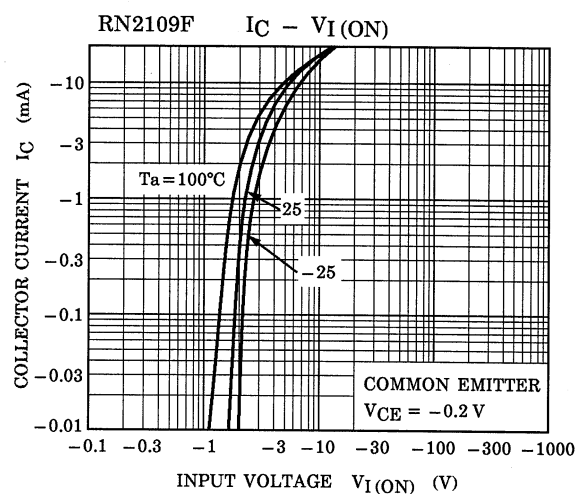
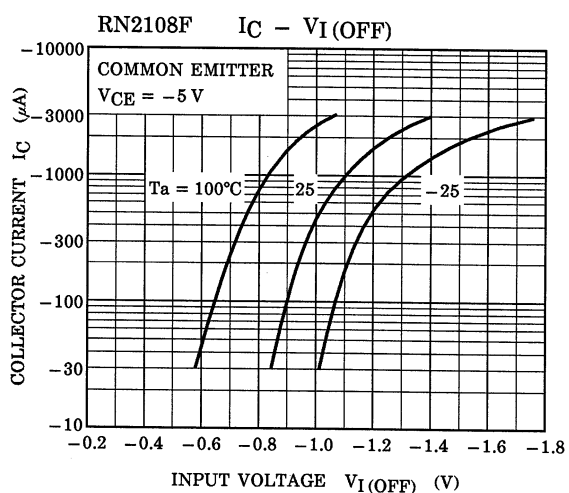
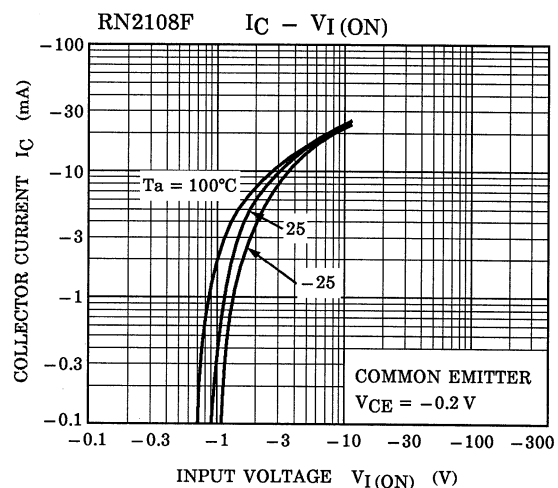
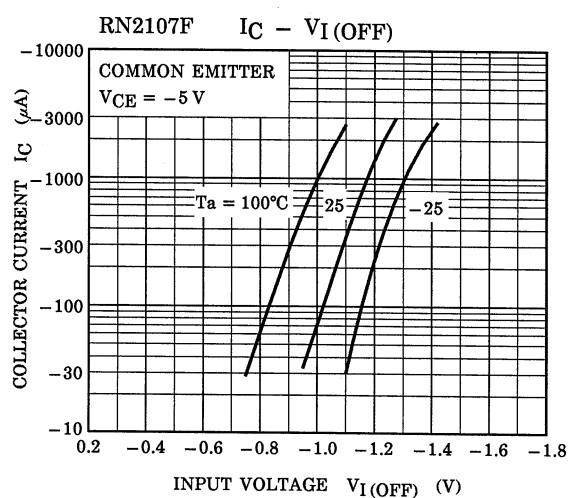
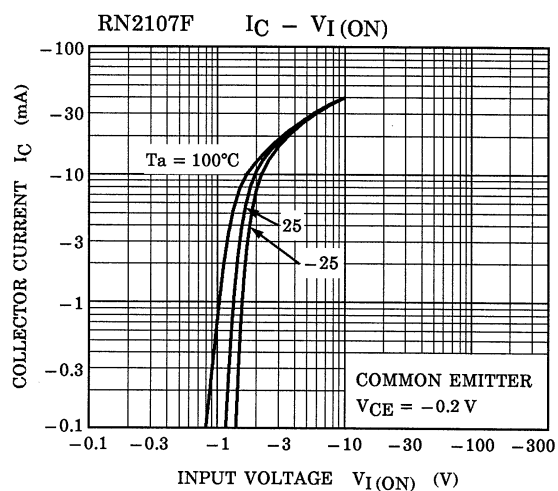
Characteristic	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	-50	V
Collector-emitter voltage	V_{CEO}	-50	V
Emitter-base voltage	V_{EBO}	-6	V
		-7	
		-15	
Collector current	I_C	-100	mA
Collector power dissipation	P_C	100	mW
Junction temperature	T_j	150	°C
Storage temperature range	T_{stg}	-55~150	°C

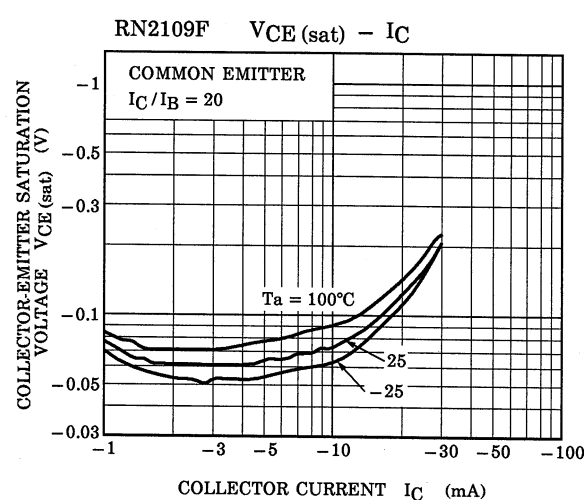
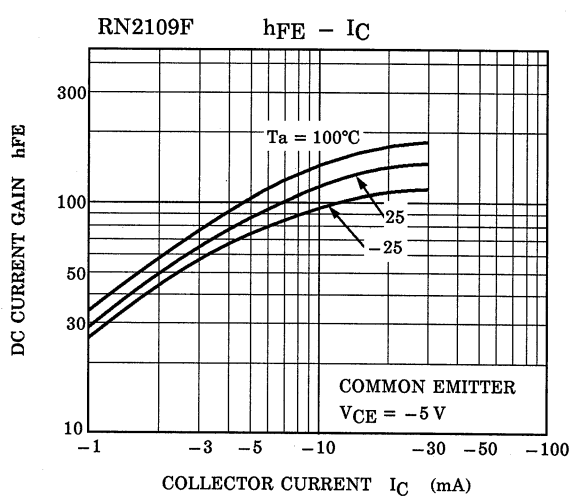
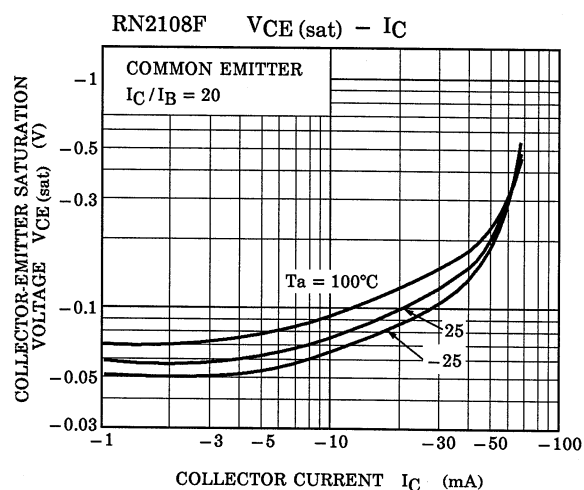
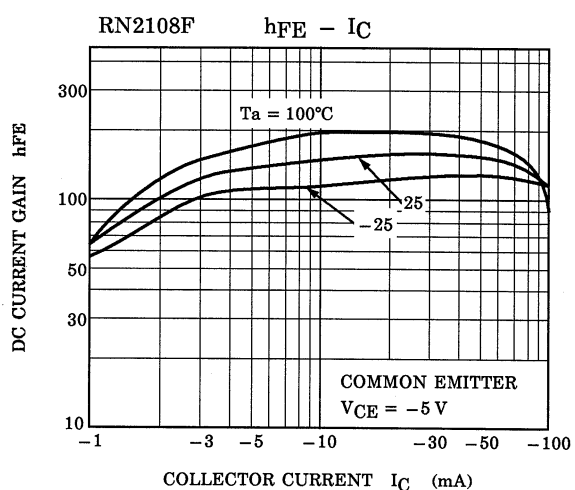
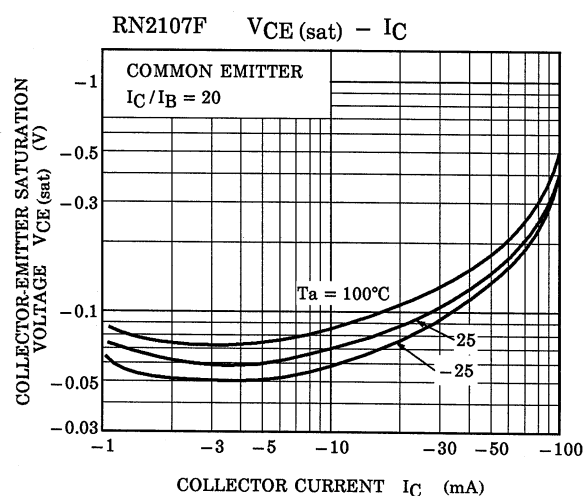
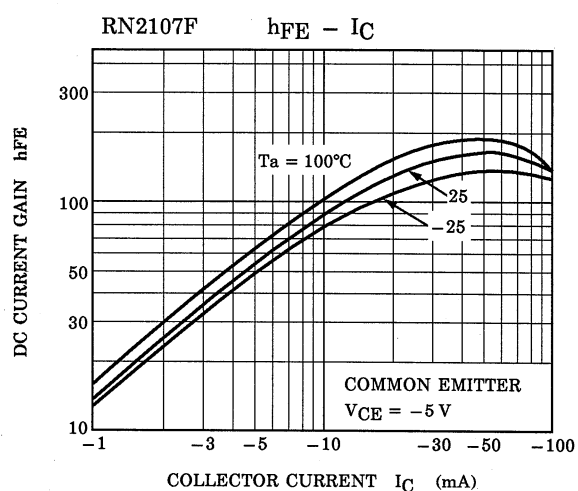
Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

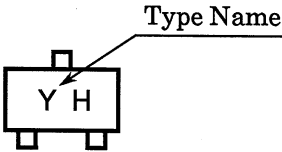
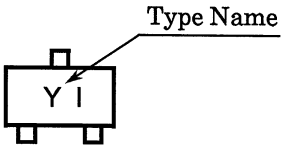
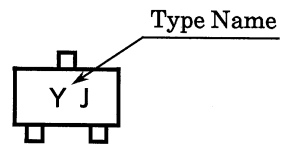
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Circuit	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	RN2107F ~RN2109F	I_{CBO}	—	$V_{CB} = -50V, I_E = 0$	—	—	-100	nA
		I_{CEO}		$V_{CE} = -50V, I_B = 0$	—	—	-500	nA
Emitter cut-off current	RN2107F	I_{EBO}	—	$V_{EB} = -6V, I_C = 0$	-0.081	—	-0.15	mA
	RN2108F			$V_{EB} = -7V, I_C = 0$	-0.078	—	-0.145	
	RN2109F			$V_{EB} = -15V, I_C = 0$	-0.167	—	-0.311	
DC current gain	RN2107F	h_{FE}	—	$V_{CE} = -5V,$ $I_C = -10mA$	80	—	—	—
	RN2108F				80	—	—	
	RN2109F				70	—	—	
Collector-emitter saturation voltage	RN2107F ~RN2109F	$V_{CE(sat)}$	—	$I_C = -5mA,$ $I_B = -0.25mA$	—	-0.1	-0.3	V
Input voltage (ON)	RN2107F	$V_I(ON)$	—	$V_{CE} = -0.2V,$ $I_C = -5mA$	-0.7	—	-1.8	V
	RN2108F				-1.0	—	-2.6	
	RN2109F				-2.2	—	-5.8	
Input voltage (OFF)	RN2107F	$V_I(OFF)$	—	$V_{CE} = -5V,$ $I_C = -0.1mA$	-0.5	—	-1.0	V
	RN2108F				-0.6	—	-1.16	
	RN2109F				-1.5	—	-2.6	
Transition frequency	RN2107F ~RN2109F	f_T	—	$V_{CE} = -10V,$ $I_C = -5mA$	—	200	—	MHz
Collector Output capacitance	RN2107F ~RN2109F	C_{ob}	—	$V_{CB} = -10V, I_E = 0,$ $f = 1MHz$	—	3	6	pF
Input resistor	RN2107F	R1	—	—	7	10	13	kΩ
	RN2108F				15.4	22	28.6	
	RN2109F				32.9	47	61.1	
Resistor ratio	RN2107F	R1/R2	—	—	0.191	0.213	0.232	—
	RN2108F				0.421	0.468	0.515	
	RN2109F				1.92	2.14	2.35	





Type Name	Marking
RN2107F	
RN2108F	
RN2109F	

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.